

**Notice of References Cited**

Application/Control No.

10/528,679

Applicant(s)/Patent Under  
Reexamination  
HOOIJMANS ET AL.

Examiner

SON P. HUYNH

Art Unit

2623

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,622,307	09-2003	Ho, Kesse	725/120
*	B	US-6,714,262	03-2004	Tsurumi, Atsushi	348/731
*	C	US-6,122,482	09-2000	Green et al.	725/68
*	D	US-6,377,315	04-2002	Carr et al.	348/726
*	E	US-5,905,941	05-1999	Chanteau, Pierre	725/127
*	F	US-6,598,231	07-2003	Basawapatna et al.	725/120
*	G	US-6,487,391	11-2002	Park, Young-Rok	455/3.02
*	H	US-5,406,558	04-1995	Rovira et al.	370/326
*	I	US-5,060,297	10-1991	Ma et al.	455/302
*	J	US-4,556,988	12-1985	Yoshisato, Akiyuki	455/182.2
*	K	US-2001/0043116	11-2001	WALTMAN, STEVEN D.	327/559
*	L	US-5,845,196	12-1998	Nawata, Hizuru	455/71
*	M	US-4,697,247	09-1987	Grinberg et al.	708/191

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.